

Cree® EZ950™ Gen 3 LEDs

Data Sheet

CxxxEZ950-Sxx000-3-x

Cree's EZBright® LEDs are the newest generation of solid-state LED emitters that combine highly efficient InGaN materials with Cree's proprietary optical design and device submount technology to deliver superior value for high-intensity LEDs. The optical design maximizes light extraction efficiency and enables a Lambertian radiation pattern. Additionally, these LEDs are die-attachable with conductive adhesive, solder paste or solder preforms, as well as flux eutectic attach. These vertically structured, low forward voltage LED chips are approximately 170 microns in height. Cree's EZ™ chips are tested for conformity to optical and electrical specifications. These LEDs are useful in a broad range of applications such as general illumination, automotive lighting and mobile flash.

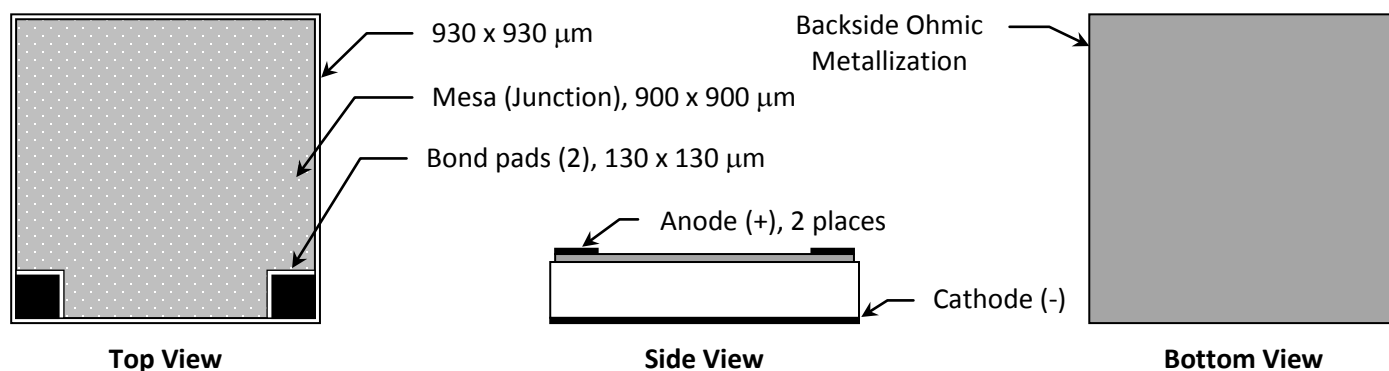
FEATURES

- EZBright LED Technology
 - » 450 nm – 440+ mW
 - » 460 nm – 420+ mW
 - » 470 nm – 400+ mW
 - » 527 nm – 170+ mW
- Lambertian Radiation Pattern
- Backside Metal versions for various attach methods:
 - » "-A" (AuSn) for use with Conductive Adhesives, Flux Eutectic Attach, Solder Paste & Solder Preforms
 - » "-G" (LTDA) for Low Temperature Flux Eutectic Attach
- Low Forward Voltage
- Dielectric Passivation across the Epi Surface
- Anode-up design

APPLICATIONS

- General Illumination
 - » Aircraft
 - » Decorative Lighting
 - » Task Lighting
 - » Outdoor Illumination
- White LEDs
- Projection Displays
- Automotive Exterior
- Mobile Flash

CxxxEZ950-Sxx000-3-x Chip Diagram





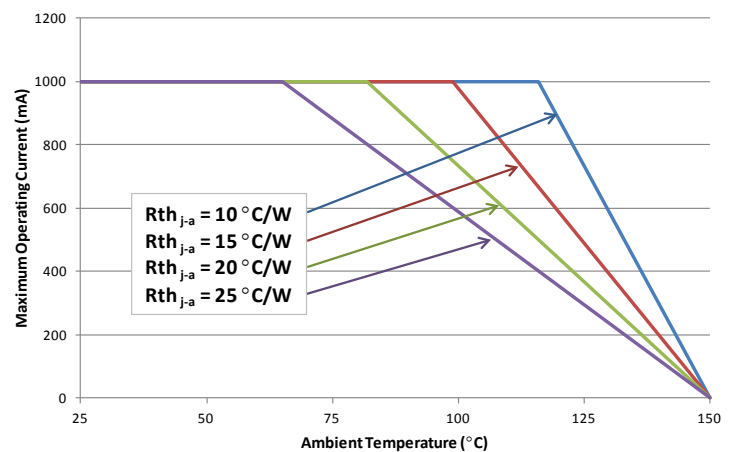
| Maximum Ratings at $T_A = 25^\circ\text{C}$ <small>Note 1, 2 & 3</small> | | CxxxEZ950-Sxx000-3-x |
|--|--|--|
| DC Forward Current | | 1000 mA |
| Peak Forward Current (1/10 duty cycle @ 1 kHz) | | 1500 mA |
| LED Junction Temperature | | 150°C |
| Reverse Voltage | | 5 V |
| Operating Temperature Range | | -40°C to +100°C |
| LED Chip Storage Temperature Range | | -40°C to +120°C |
| Recommended Die Sheet Storage Conditions | | $\leq 30^\circ\text{C}$ / $\leq 85\%$ RH |

| Typical Electrical/Optical Characteristics at $T_A = 25^\circ\text{C}$, $I_f = 350\text{ mA}$ <small>Note 2</small> | | | | | |
|--|------------------------------|------|------|---|--|
| Part Number | Forward Voltage (V_f , V) | | | Reverse Current [$I(V_r=5V)$, μA] | Full Width Half Max (λ_{DF} , nm) |
| | Min. | Typ. | Max. | Max. | Typ. |
| C450EZ950-Sxx000-3-x | 2.7 | 3.1 | 3.4 | 2 | 20 |
| C460EZ950-Sxx000-3-x | 2.7 | 3.1 | 3.4 | 2 | 21 |
| C470EZ950-Sxx000-3-x | 2.7 | 3.1 | 3.4 | 2 | 22 |
| C527EZ950-Sxx000-3-x | 2.8 | 3.25 | 3.8 | 2 | 35 |

| Mechanical Specifications | | CxxxEZ950-Sxx000-3-x | |
|--|------------|----------------------|--|
| Description | Dimensions | Tolerance | |
| P-N Junction Area (μm) | 900 x 900 | ± 35 | |
| Chip Area (μm) | 930 x 930 | ± 35 | |
| Chip Thickness (μm) | 170 | ± 25 | |
| Top Au Bond Pad (μm) - Qty. 2 | 130 x 130 | ± 25 | |
| Au Bond Pad Thickness (μm) | 1.0 | ± 0.5 | |
| Backside Ohmic Metal Area (μm) | 930 x 930 | ± 35 | |
| Backside Ohmic Metal Thickness (μm) - "-A" (AuSn) | 3.0 | ± 1.5 | |
| Backside Ohmic Metal Thickness (μm) - "-G" (LTDA) | 3.3 | ± 1.5 | |

Notes:

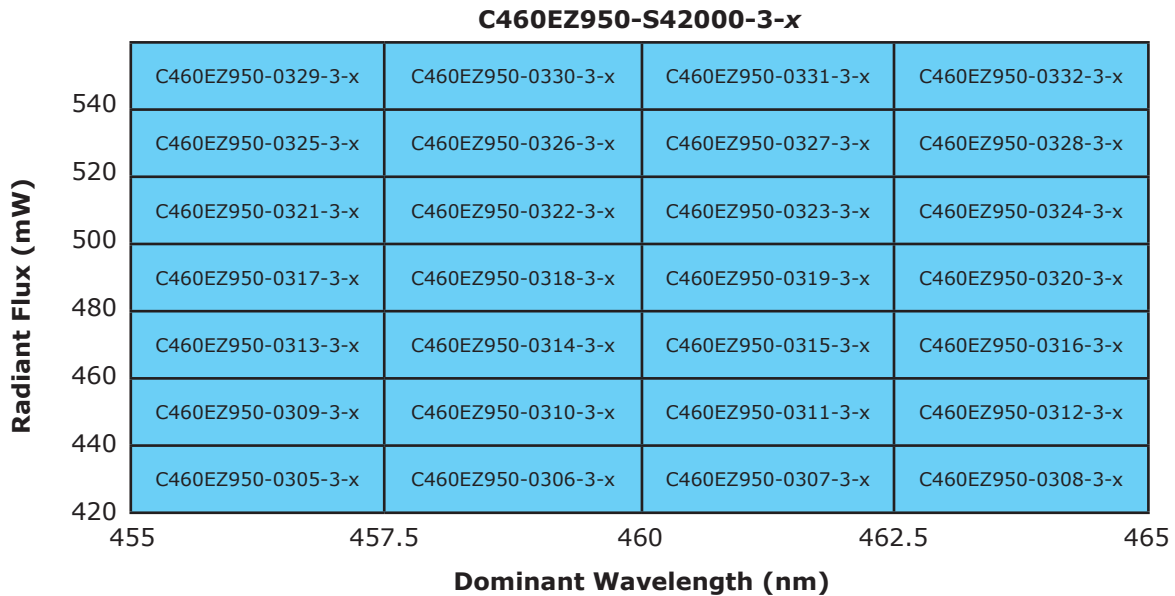
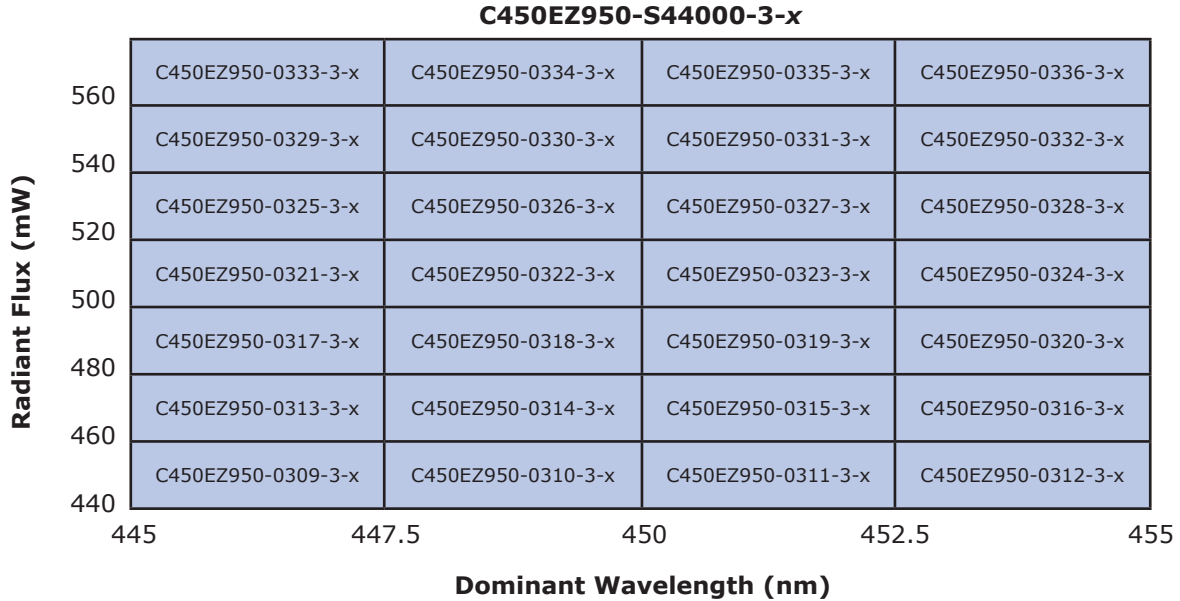
- Maximum ratings are package-dependent. The above ratings were determined using a silicone encapsulated chip on MCPCB for characterization. Ratings for other packages may differ. The junction temperature should be characterized in a specific package to determine limitations. Assembly processing temperature must not exceed 325°C (< 5 seconds). See the Cree EZBright Applications Note for assembly-process information.
- All products conform to the listed minimum and maximum specifications for electrical and optical characteristics when assembled and operated at 350 mA within the maximum ratings shown above. Efficiency decreases at higher currents. Typical values given are within the range of average values expected by the manufacturer in large quantities and are provided for information only. All measurements were made using a Au-plated TO header without an encapsulant. Optical characteristics were measured in an integrating sphere using Illuminance E.
- The maximum forward current is determined by the thermal resistance between the LED junction and ambient. It is crucial for the end-product to be designed in a manner that minimizes the thermal resistance from the LED junction to ambient in order to optimize product performance.





Standard Bins for CxxxEZ950-Sxx000-3-x

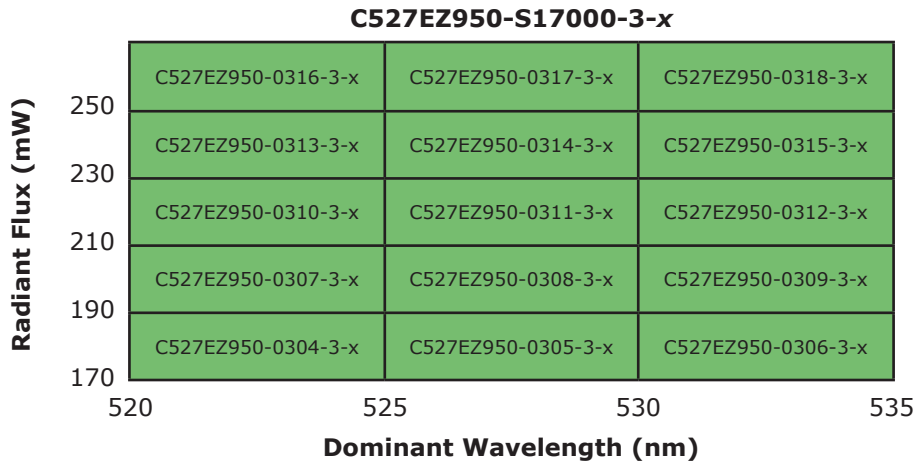
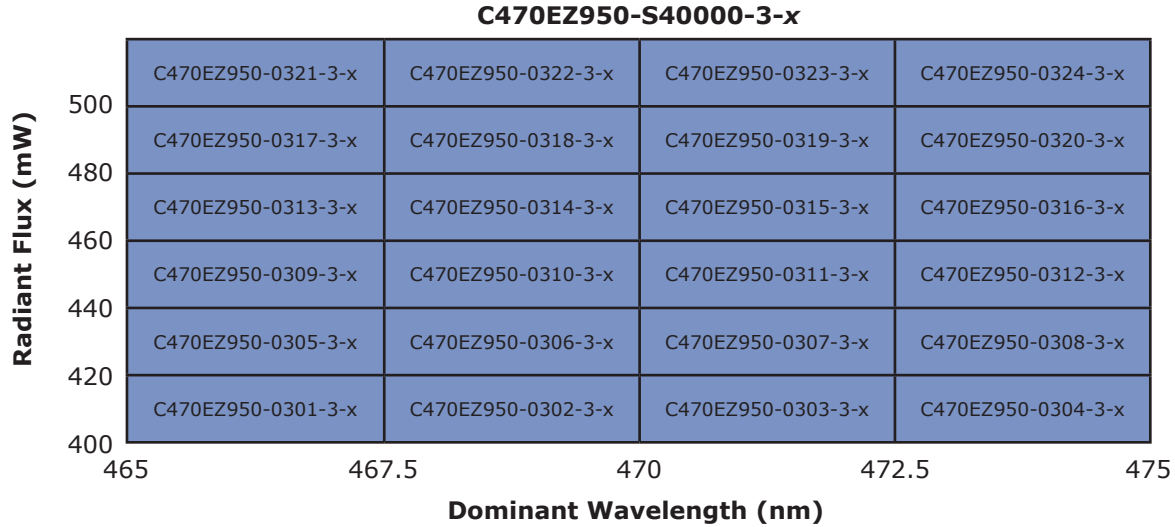
LED chips are sorted to the **radiant flux** and **dominant wavelength** bins shown. A sorted die sheet contains die from only one bin. Sorted die kit (CxxxEZ950-Sxx000-3-x) orders may be filled with any or all bins (CxxxEZ950-0xxx-3-x) contained in the kit. All radiant flux and dominant wavelength values shown and specified are at $I_f = 350$ mA. Radiant flux values are measured using Au-plated headers without an encapsulant.





Standard Bins for CxxxEZ950-Sxx000-3-x

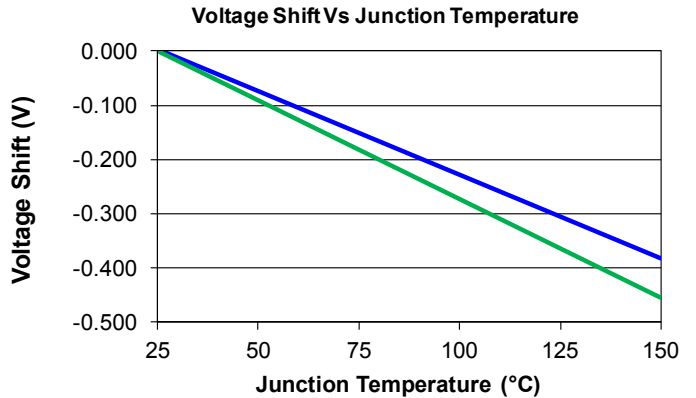
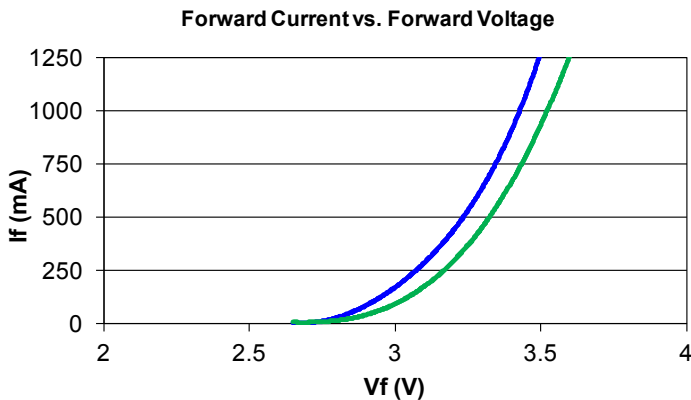
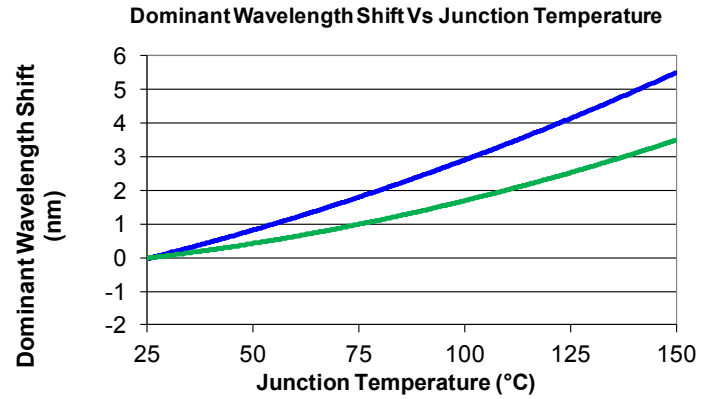
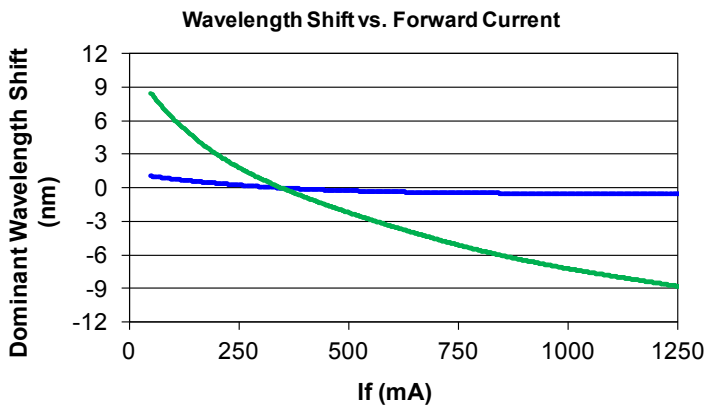
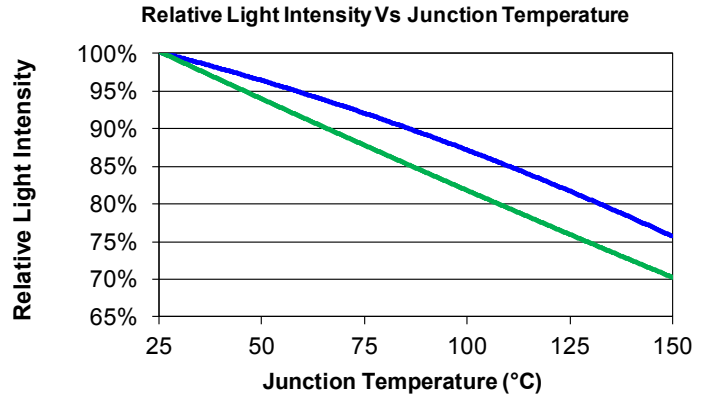
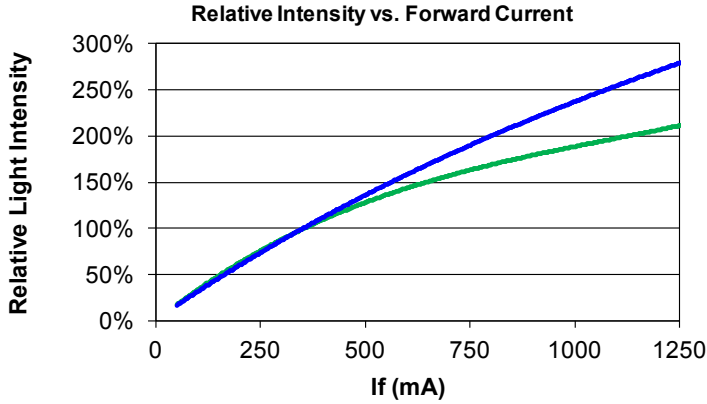
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Characteristic Curves, $T_A = 25^\circ\text{C}$

This is a representative measurement for the EZ950™ Gen 3 LED product. Actual curves will vary slightly for the various radiant flux and dominant wavelength bins.





Radiation Pattern

This is a representative radiation pattern for the EZ Gen 3 LED product. Actual patterns will vary slightly for each chip.

